

RoHS Compliant Product
A suffix of "-C" specifies halogen free

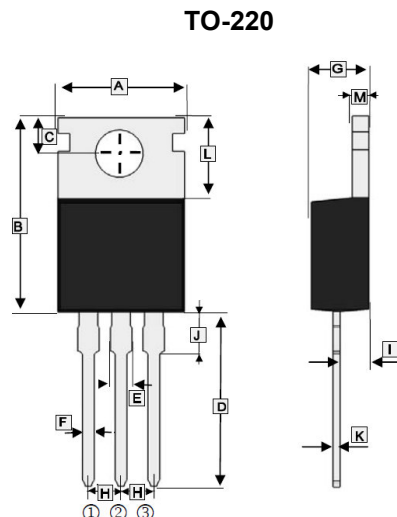
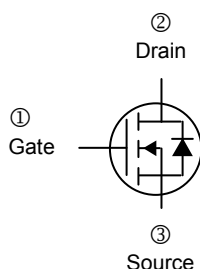
DESCRIPTION

The SSQ130N80SG is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications. The SSQ130N80SG meet the RoHS and Green Product with Function reliability approved.

FEATURES

- $R_{DS(on)} \leq 5.8m\Omega @ V_{GS}=10V$
- $R_{DS(on)} \leq 8m\Omega @ V_{GS}=4.5V$
- High speed power switching, Logic Level
- Enhanced Body diode dv/dt capability
- Enhanced Avalanche Ruggedness
- 100% UIS Tested, 100% Rg Tested
- TO-220 Package

MARKING



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	9.96	10.36	H	2.54	BSC.
B	14.7	16	I	2.04	2.92
C	2.74 BSC.		J	3.745 REF.	
D	12.7	14.73	K	0.356	0.5
E	1.15	1.82	L	5.85	6.85
F	0.39	1.01	M	0.51	1.39
G	3.56	4.82			

ABSOLUTE MAXIMUM RATINGS ($T_J=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V_{DS}	80	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current (Silicon Limited)	I_D	$T_C=25^\circ C$	130
		$T_C=100^\circ C$	92
Continuous Drain Current (Package Limited)	$T_C=25^\circ C$	120	A
Pulsed Drain Current	I_{DM}	380	A
Avalanche Energy, Single Pulse, @L=0.3mH	$T_C=25^\circ C$	E_{AS}	240 mJ
Power Dissipation	$T_C=25^\circ C$	P_D	176 W
Operating Junction and Storage Temperature Range	T_J, T_{STG}	-55 ~ 175	$^\circ C$
Thermal Resistance Ratings			
Maximum Thermal Resistance Junction-Ambient	$R_{\theta JA}$	65	$^\circ C / W$
Maximum Thermal Resistance Junction-Case	$R_{\theta JC}$	0.85	

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ C$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test conditions	
Drain-Source Breakdown Voltage	BV_{DSS}	80	-	-	V	$V_{GS}=0, I_D=250\mu A$	
Gate Threshold Voltage	$V_{GS(th)}$	1	1.7	2.4	V	$V_{DS}=V_{GS}, I_D=250\mu A$	
Forward Transfer conductance	g_{fs}	-	65	-	S	$V_{DS}=5V, I_D=20A$	
Gate-Source Leakage Current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 20V$	
Drain-Source Leakage Current	I_{DSS}	$T_J=25^\circ C$	-	-	1	μA	$V_{DS}=80V, V_{GS}=0$
		$T_J=100^\circ C$	-	-	100		
Static Drain-Source On-Resistance	$R_{DS(ON)}$	-	4.3	5.8	m Ω	$V_{GS}=10V, I_D=20A$	
		-	5.9	8		$V_{GS}=4.5V, I_D=20A$	
Total Gate Charge	Q_g	-	46	-	nC	$V_{GS}=10V$	
		-	22	-		$V_{GS}=4.5V$	
Gate-Source Charge	Q_{gs}	-	9	-		$I_D=20A$	
Gate-Drain ("Miller") Change	Q_{gd}	-	8	-	$V_{DD}=40V$ $V_{GS}=10V$		
Turn-on Delay Time	$T_{d(on)}$	-	11	-	nS	$V_{DD}=40V$ $I_D=20A$ $V_{GS}=10V$ $R_G=10\Omega$	
Rise Time	T_r	-	7	-			
Turn-off Delay Time	$T_{d(off)}$	-	38	-			
Fall Time	T_f	-	9	-			
Input Capacitance	C_{iss}	-	3130	-	pF	$V_{GS}=0$ $V_{DS}=40V$ $f=1.0MHz$	
Output Capacitance	C_{oss}	-	385	-			
Reverse Transfer Capacitance	C_{rss}	-	18	-			
Source-Drain Diode							
Forward On Voltage	V_{SD}	-	0.9	1.2	V	$I_F=20A, V_{GS}=0$	
Reverse Recovery Time	T_{rr}	-	48	-	nS	$V_R=40V, I_F=20A, di/dt=400A/\mu s$	
Reverse Recovery Charge	Q_{rr}	-	190	-	nC		

TYPICAL CHARACTERISTICS CURVE

Fig 1. Typical Output Characteristics

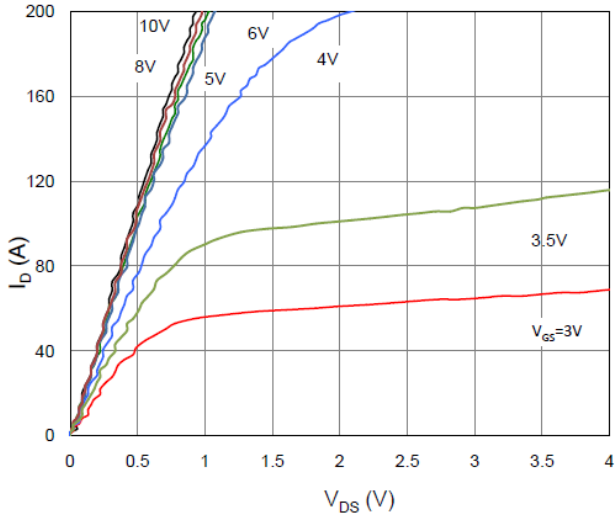


Figure 2. On-Resistance vs. Gate-Source Voltage

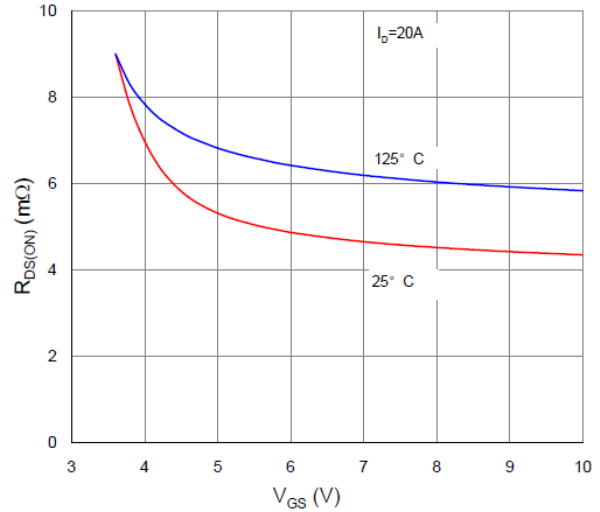


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

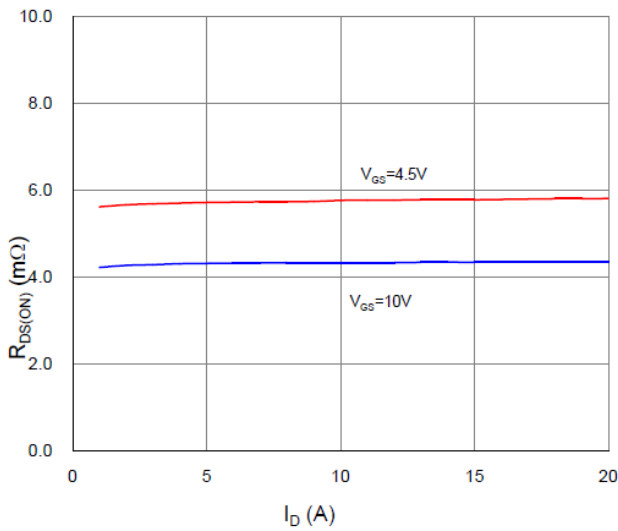


Figure 4. Normalized On-Resistance vs. Junction Temperature

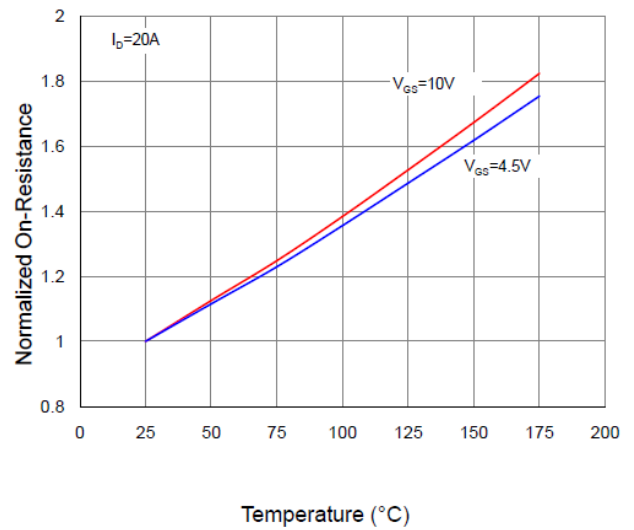


Figure 5. Typical Transfer Characteristics

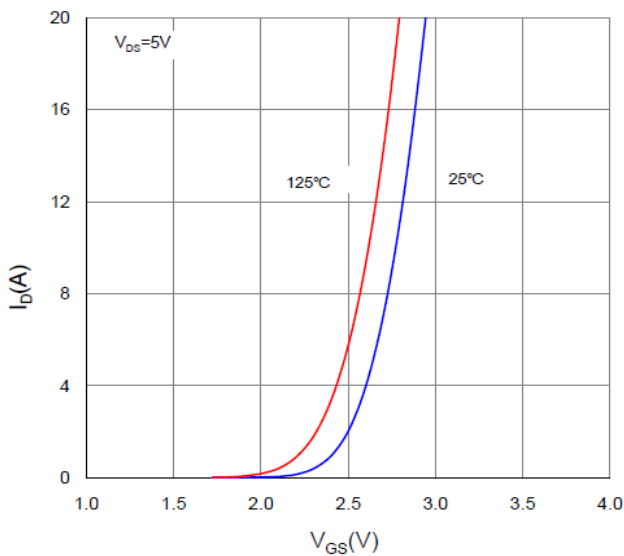
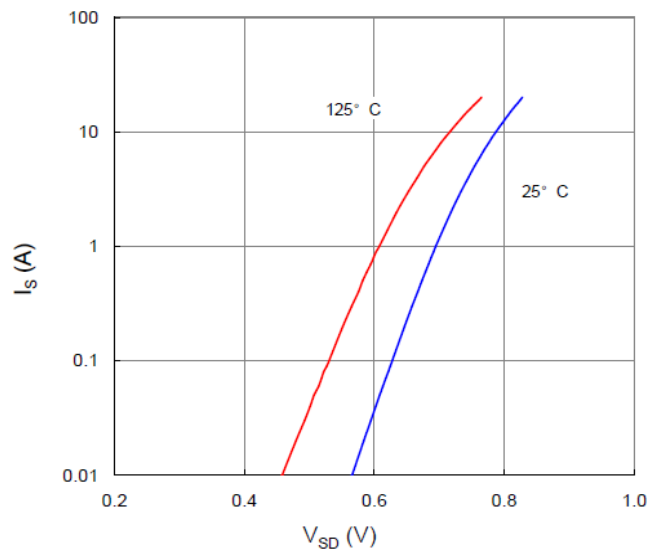


Figure 6. Typical Source-Drain Diode Forward Voltage



TYPICAL CHARACTERISTICS CURVE

Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage

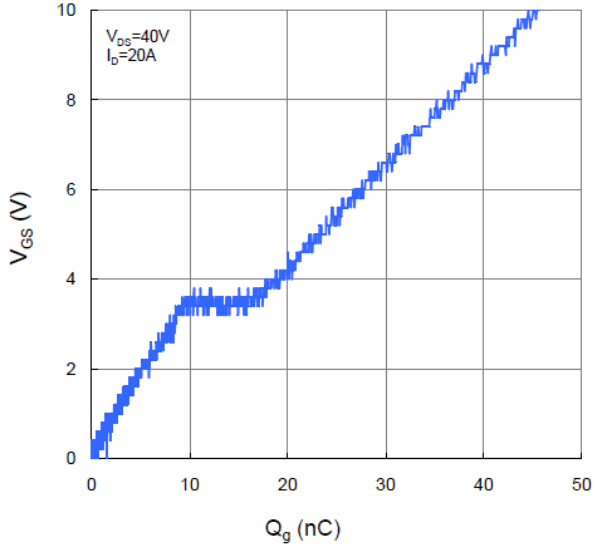


Figure 8. Typical Capacitance vs. Drain-to-Source Voltage

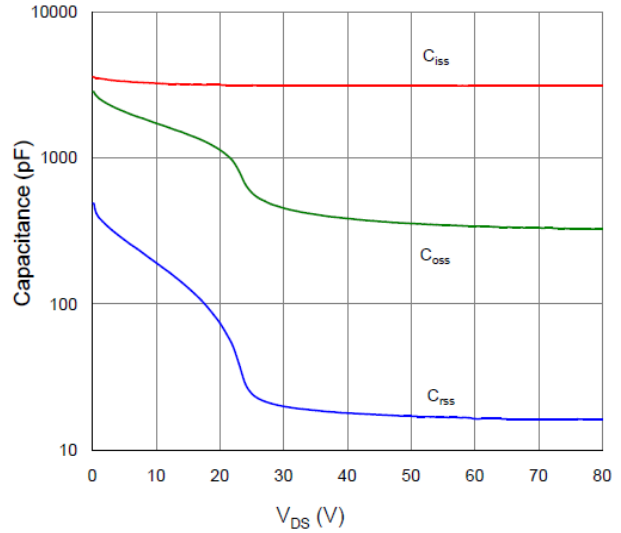


Figure 9. Maximum Safe Operating Area

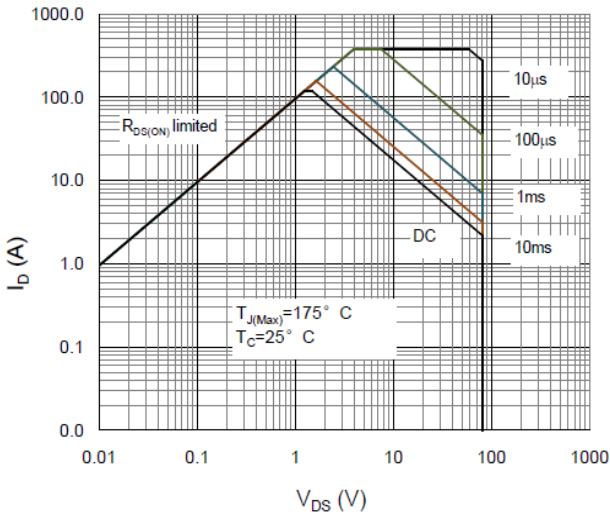


Figure 10. Maximum Drain Current vs. Case Temperature

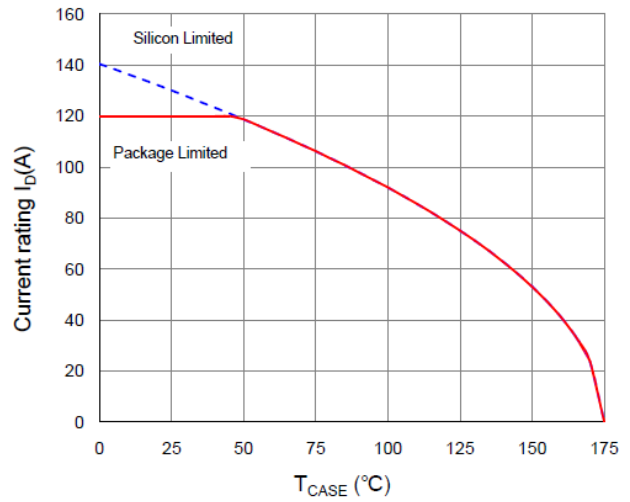


Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Case

